

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10092101	LEYMASTER ET AL.
	<b>Examiner</b>	<b>Art Unit</b>
	Quoc, Tran A	2176

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
715	530, 506-508, 526,	3/27/2007	QT
705	38	3/27/2007	QT
Updated 715	500 and all sub-classes	11/12/2007	QT
Updated Above	Updated Above	7/11/2008	QT
Updated 715	Updated Subclasses 715/219-230 & 715/273	2/19/2009	QT
Updated	Updated 715/219-230 & 715/273 & 715/224; 715/231-23; 715/748-749 and 715/7632	11/8/2009	QT

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
Updated search EAST (USPAT, USPGPUB, JPO, USOCR, FPRS, EPO, DERWENT & IBM TDB)	3/27/2007	QT
Updated search EAST (USPAT, USPGPUB, JPO, USOCR, FPRS, EPO, DERWENT & IBM TDB)	11/12/2007	QT
Updated Above	7/11/2008	QT
Updated Above	2/19/2009	QT
Updated NPL Search (ACM digital library)	2/19/2009	QT
Updated Inventors search, considering Double Patent	2/19/2009	QT
Updated Text Search Class 715/219-230 & 715/273	2/19/2009	QT
Updated Above	11/8/2009	QT
TEXT searched Updated 715/219-230 & 715/273 & 715/224; 715/231-231; 715/748-749 and 715/763	11/8/2009	QT
EAST Searched "Allowable Subject Matter" conducted	11/8/2009	QT
Interference Searched	11/8/2009	QT

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
705	17, 44	11/8/2009	QT
706	46	11/8/2009	QT

/Q. A. T./  
Examiner.Art Unit 2176